



RMWL26001

21-26.5 GHz Low Noise Amplifier MMIC

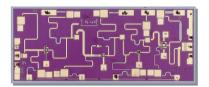
General Description

The RMWL26001 is a 4-stage GaAs MMIC amplifier designed as a 21 to 26.5 GHz Low Noise Amplifier for use in point to point and point to multi-point radios, and various communications applications. In conjunction with other Fairchild RF Components amplifiers, multipliers and mixers it forms part of a complete 26 GHz transmit/receive chipset. The RMWL26001 utilizes our 0.25µm power PHEMT process and is sufficiently versatile to serve in a variety of low noise amplifier applications.

Features

- 4 mil substrate
- Small-signal gain 21dB (typ.)
- 2.9dB noise figure (typ.)
- Chip size 3.0mm x 1.25mm

Device



Absolute Ratings

| Symbol | Parameter | Ratings | Units |
|------------------|--|-------------|-------|
| Vd | Positive DC voltage (+4V Typical) | +6 | V |
| Vg | Negative DC voltage | -2 | V |
| Vdg | Simultaneous (Vd–Vg) | 8 | V |
| I_D | Positive DC Current | 100 | mA |
| P _{IN} | RF Input Power (from 50Ω source) | +8 | dBm |
| T _C | Operating Baseplate Temperature | -30 to +85 | °C |
| T _{stg} | Storage Temperature Range | -55 to +125 | °C |
| R _{ic} | Thermal Resistance (Channel to Backside) | 170 | °C/W |

Electrical Characteristics (At 25°C), 50 Ω system, Vd = +4V, Quiescent current (Idg) = 65 mA

| Parameter | Min | Тур | Max | Units |
|--|-----|-----|------|-------|
| Frequency Range | 21 | | 26.5 | GHz |
| Gate Supply Voltage ¹ (Vg) | | 0.5 | | V |
| Gain at Pin = -15dBm (21–24GHz) | 20 | 22 | 26 | dB |
| Gain at Pin = -15dBm (21–26.5GHz) | 20 | 21 | 26 | dB |
| GainVariation vs Freq. (21–26.5GHz) | | 2.8 | | dB |
| Gain at 1 dBm Compression (21–26.5GHz) | | 20 | | dB |
| Power Output at 1dB Compression | | 10 | | dBm |
| Drain Current at Pin = -15dBm | | 65 | | mA |
| Drain Current at 1dB Compression | | 80 | | mA |
| Input Return Loss (Pin = -15dBm) | | 12 | | dB |
| Output Return Loss (Pin = -15dBm) | | 12 | | dB |
| Noise Figure | | 2.9 | 4.0 | dB |
| OIP3 | | 22 | | dBm |

Note:

Application Information

CAUTION: THIS IS AN ESD SENSITIVE DEVICE.

Chip carrier material should be selected to have GaAs compatible thermal coefficient of expansion and high thermal conductivity such as copper molybdenum or copper tungsten. The chip carrier should be machined, finished flat, plated with gold over nickel and should be capable of withstanding 325°C for 15 minutes.

Die attachment should utilize Gold/Tin (80/20) eutectic alloy solder and should avoid hydrogen environment for PHEMT devices. Note that the backside of the chip is gold plated and is used as RF and DC ground.

These GaAs devices should be handled with care and stored in dry nitrogen environment to prevent contamination of bonding surfaces. These are ESD sensitive devices and should be handled with appropriate precaution including the use of wrist grounding straps. All die attach and wire/ribbon bond equipment must be well grounded to prevent static discharges through the device.

Recommended wire bonding uses 3 mils wide and 0.5 mil thick gold ribbon with lengths as short as practical allowing for appropriate stress relief. The RF input and output bonds should be typically 0.012" long corresponding to a typical 2 mil gap between the chip and the substrate material.

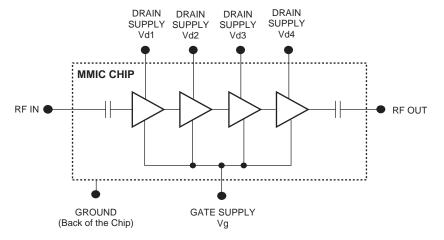


Figure 1. Functional Block Diagram

^{1:} Typical range of negative gate voltage is -0.8 to -0.2 V to set typical Idq of 65 mA

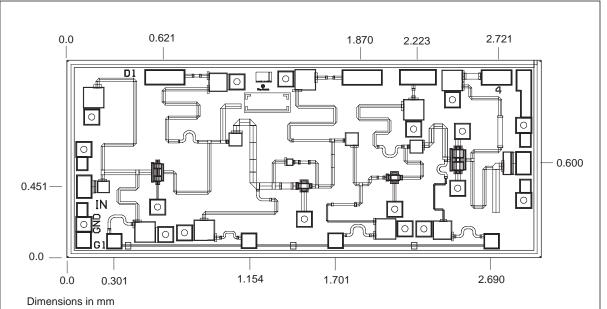


Figure 2. Chip Layout and Bond Pad Locations (Chip Size is 3.0mm x 1.25mm x 100 μ m. Back of chip is RF and DC Ground)

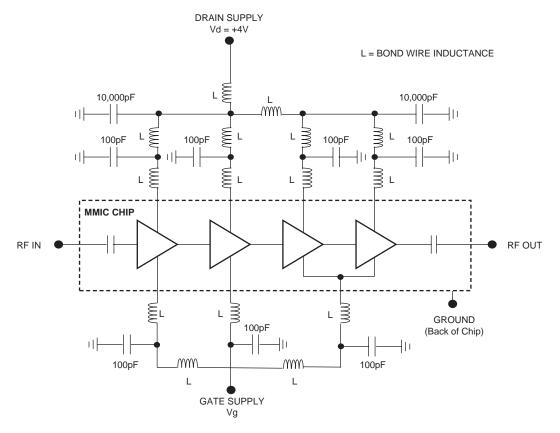
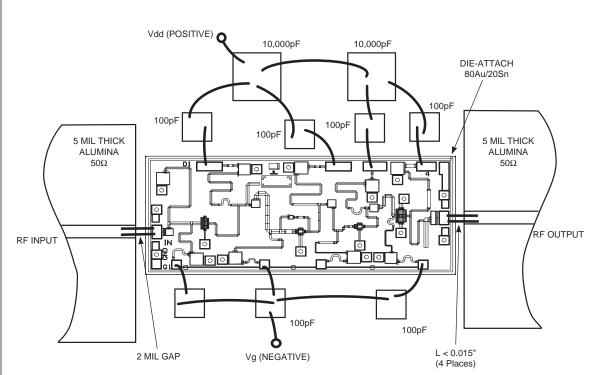


Figure 3. Recommended Application Schematic Circuit Diagram



Note:

Use 0.003" by 0.0005" Gold Ribbon for bonding. RF input and output bonds should be less than 0.015" long with stress relief.

Figure 4. Recommended Assembly Diagram

Recommended Procedure for Biasing and Operation

CAUTION: LOSS OF GATE VOLTAGE (VG) WHILE DRAIN VOLTAGE (VD) IS PRESENT MAY DAMAGE THE AMPLIFIER CHIP.

The following sequence of steps must be followed to properly test the amplifier:

Step 1: Turn off RF input power.

Step 2: Connect the DC supply grounds to the grounds of the chip carrier. Slowly apply negative gate bias supply voltage of -1.5V to Vg.

Step 3: Slowly apply positive drain bias supply voltage of +4V to Vd.

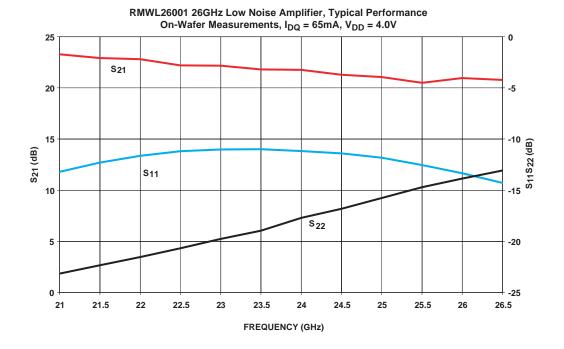
Step 4: Adjust gate bias voltage to set the quiescent current of Idq = 65mA.

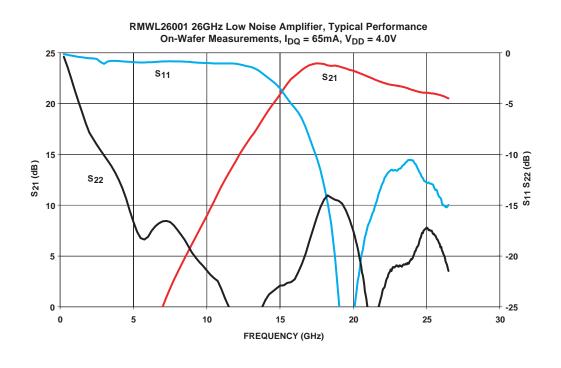
Step 5: After the bias condition is established, RF input signal may now be applied at the appropriate frequency band.

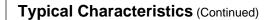
Step 6: Follow turn-off sequence of:

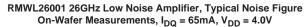
- (i) Turn off RF input power,
- (ii) Turn down and off drain voltage (Vd),
- (iii) Turn down and off gate bias voltage (Vg).

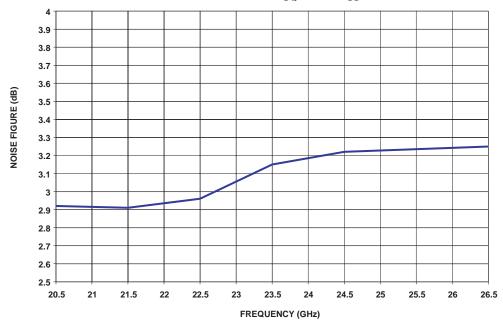




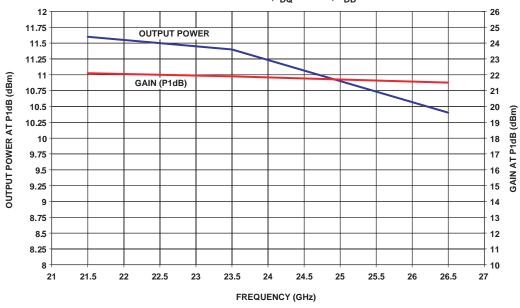


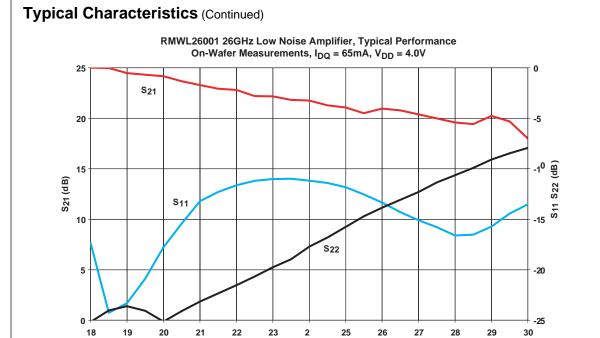






RMWL26001 26GHz Low Noise Amplifier, Typical Performance On-Wafer Measurements, $I_{DQ} = 65mA$, $V_{DD} = 4.0V$





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